#### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

#### **DESCRIPTION**

The M5M5V416CWG is a family of low voltage 4-Mbit static RAMs - Single 2.7~3.6V power supply organized as 262144-words by 16-bit, fabricated by Renesas's high-performance 0.18µm CMOS technology.

The M5M5V416C is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

M5M5V416CWG is packaged in a CSP (chip scale package), with the outline of 7.0mm x 8.5mm, ball matrix of 6 x 8 (48ball) and ball pitch of 0.75mm. It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

#### **FEATURES**

- Small stand-by current: 0.2µA (3.00V, typ.)
- No clocks. No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE# prevents data contention in the I/O bus
- Process technology: 0.18µm CMOS
- Package: 48ball 7.0mm x 8.5mm CSP

| Version,                 | Part name         |            |      | Stand-by current (µA) |      |                      |      |      |      |        | Activ e      |                |
|--------------------------|-------------------|------------|------|-----------------------|------|----------------------|------|------|------|--------|--------------|----------------|
| Operating                |                   |            |      | * Typical(3.0V)       |      | Ratings (max. @3.6V) |      |      |      | )      | current      |                |
| temperature              |                   | Supply     | max. | 25°C                  | 40°C | Voltage              | 25°C | 40°C | 70°C | 85°C   | (3.0V, typ.) |                |
| I-version<br>-40 ~ +85°C | M5M5V416CWG -55HI |            | 55ns |                       |      | 3.0V                 | 1.0  | 2.0  | 10   | 20     | 30mA         |                |
|                          |                   | 2.7 ~ 3.6V |      |                       | 0.2  | 0.4                  | 3.3V | 1.5  | 2.5  | 10     | 20           | (10MHz)<br>5mA |
|                          | M5M5V416CWG -70HI | 70ns       |      |                       | 3.6V | 2.5                  | 4.0  | 10   | 20   | (1MHz) |              |                |

<sup>\*</sup> Typical parameter indicates the value for the center of distribution, and not 100% tested.

### PIN CONFIGURATION

#### (TOP VIEW)

| A | 1<br>(BC1#) | 2<br>(OE#) | 3<br>(A0)    | 4<br>(A1) | 5<br>A2 | 6<br>(\$2 |  |
|---|-------------|------------|--------------|-----------|---------|-----------|--|
| В | DQ16        | BC2#       | (A3)         | (A4)      | S1#     | (DQ1)     |  |
| С | DQ14        | (DQ15)     | (A5)         | (A6)      | (DQ2)   | DQ3       |  |
| D | GND         | (DQ13)     | (A17)        | (A7)      | DQ4     | VCC       |  |
| E | VCC         | (DQ12)     | NC or<br>GND | (A16)     | DQ5     | GND       |  |
| F | (DQ11)      | (DQ10)     | (A14)        | (A15)     | DQ7     | DQ6       |  |
| G | DQ9         | N.C.       | (A12)        | (A13)     | W#      | (DQ8)     |  |
| Н | NC          | (A8)       | (A9)         | (A10)     | (A11)   | N.C.      |  |

Outline: 48FJA NC: No Connection

\*Don't connect E3 ball to voltage level more than 0V.

| Pin        | Function              |
|------------|-----------------------|
| A0 ~ A17   | Address input         |
| DQ1 ~ DQ16 | Data input / output   |
| S1#        | Chip select input 1   |
| S2         | Chip select input 2   |
| W#         | Write control input   |
| OE#        | Output enable input   |
| BC1#       | Lower Byte (DQ1 ~ 8)  |
| BC2#       | Upper Byte (DQ9 ~ 16) |
| Vcc        | Power supply          |
| GND        | Ground supply         |



### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

#### **FUNCTION**

The M5M5V416CWG is organized as 262144-words by 16-bit. These devices operate on a single +2.7~3.6V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S1#, S2 , W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address(A0~A17) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1# and S2 are in an active state(S1#=L,S2=H).

When setting BC1# at the high level and other pins are in an active stage, upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as  $0.2\mu A(25^{\circ}C,$  typical), and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

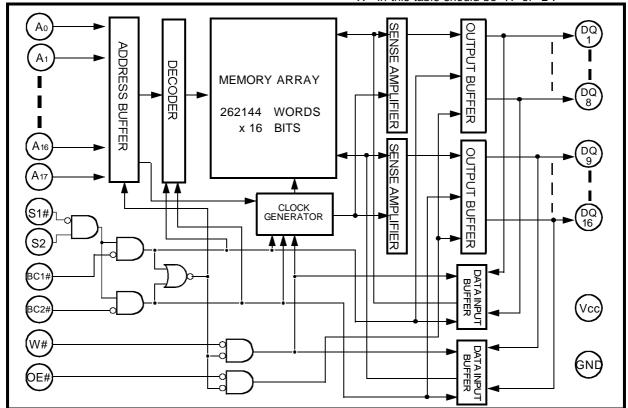
#### **FUNCTION TABLE**

| S1# | S2 | BC1# | BC2# | W# | OE# | Mode          | DQ1~8  | DQ9~16 | lcc     |
|-----|----|------|------|----|-----|---------------|--------|--------|---------|
| Χ   | L  | Χ    | Χ    | Χ  | Χ   | Non selection | High-Z | High-Z | Standby |
| Н   | Η  | Χ    | Χ    | Χ  | Χ   | Non selection | High-Z | High-Z | Standby |
| Χ   | Χ  | Н    | Η    | Χ  | Χ   | Non selection | High-Z | High-Z | Standby |
| L   | Ι  | L    | Η    | L  | Χ   | Write         | Din    | High-Z | Activ e |
| L   | Ι  | L    | Н    | Τ  | L   | Read          | Dout   | High-Z | Activ e |
| L   | Τ  | L    | Η    | Η  | Η   |               | High-Z | High-Z | Activ e |
| L   | Η  | Н    | L    | L  | Χ   | Write         | High-Z | Din    | Activ e |
| L   | Н  | Н    | L    | Н  | L   | Read          | High-Z | Dout   | Activ e |
| L   | Η  | Н    | L    | Н  | Н   |               | High-Z | High-Z | Activ e |
| L   | Η  | L    | L    | L  | Χ   | Write         | Din    | Din    | Activ e |
| L   | Η  | L    | L    | Τ  | L   | Read          | Dout   | Dout   | Activ e |
| L   | Ι  | L    | L    | Τ  | Η   |               | High-Z | High-Z | Activ e |

(note) "H" and "L" in this table mean VIH and VIL, respectively.

BLOCK DIAGRAM

"X" in this table should be "H" or "L".



### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

### **ABSOLUTE MAXIMUM RATINGS**

| Symbol | Parameter             | Conditions          | Ratings           | Units |
|--------|-----------------------|---------------------|-------------------|-------|
| Vcc    | Supply voltage        | With respect to GND | -0.5* ~ +4.6      |       |
| Vı     | Input voltage         | With respect to GND | -0.3* ~ Vcc + 0.3 | V     |
| Vo     | Output voltage        | With respect to GND | 0 ~ Vcc           |       |
| Pd     | Power dissipation     | Ta=25°C             | 700               | mW    |
| Ta     | Operating temperature | I-v ersion          | - 40 ~ +85        | °C    |
| Tstg   | Storage temperature   |                     | - 65 ~ +150       | °C    |

<sup>\* -3.0</sup>V in case of AC (Pulse width  $\leq$  30ns)

### DC ELECTRICAL CHARACTERISTICS

( Vcc=2.7 ~ 3.6V, unless noted. )

|        | _                                   |  |          |             |           |        | Limits | 3        |       |  |
|--------|-------------------------------------|--|----------|-------------|-----------|--------|--------|----------|-------|--|
| Symbol | Parameter                           | Conditions   |          |             |           | Min    | Тур    | Max      | Units |  |
| V⊪     | High-level input voltage            |  |          |             |           | 2.2    |        | Vcc+0.2V |       |  |
| ٧L     | Low-lev el input v oltage           |  |          |             |           | -0.2 * |        | 0.4      | V     |  |
| Vон    | High-level output voltage           | Iон= -0.5mA  |          |             |           | 2.4    |        |          | V     |  |
| VaL    | Low-level output voltage            | Iα=2mA   |          |             |           |        |        | 0.4      |       |  |
| - lı   | Input leakage current               | Vi=0 ~ Vcc   |          |             |           |        | ±1     | μA       |       |  |
| lo     | Output leakage current              | BC1#and BC2#=VIH or S1#=VIH or S2=VIL or OE#=VIH, VIO=0 ~ Vcc  |          |             |           |        | ±1     | μΛ       |       |  |
| lcc1   | Active supply current               | BC1# and BC2# $\leq$ 0.2V, S1# $\leq$ 0.2V, S2 $\geq$ Vcc-0.2V other inputs $\leq$ 0.2V or $\geq$ Vcc-0.2V |          | f           | f= 10MHz  | -      | 30     | 50       |       |  |
| ICC I  | ( AC,MOS level )                    | 01.0. 1.pd.0 <u>3</u> 0.2.7 0. <u>2</u> 100 0.2.7  |          | f           | f= 1MHz   | -      | 5      | 10       | mA    |  |
| l      | Active supply current               | BC1# and BC2# =V L, S1# =V L, S2 other pins =V H or V L  | =V IH    | f           | f= 10MHz  | -      | 30     | 50       | , \   |  |
| lcc2   | ( AC,TTL level )                    | Output - open (duty 100%)  |          | f           | f= 1MHz   | -      | 5      | 10       |       |  |
|        |                                     |  |          |             | 3.0V      |        |        | 1.0      |       |  |
|        |                                     | (1) S1# ≥ Vcc-0.2V,  | ~ +25°   | С           | 3.3V      | -      | 0.2    | 1.5      |       |  |
|        |                                     | S2 ≥ Vcc-0.2V,   |          |             | 3.6V      |        |        | 2.5      |       |  |
| Icc3   | Stand by supply current             | other inputs = $0 \sim Vcc$<br>(2) $S2 \le 0.2V$ ,   |          |             | 3.0V      |        |        | 2.0      |       |  |
|        | ( MOS level )                       | other inputs = 0 ~ Vcc<br>(3) BC1# and BC2# > Vcc - 0.2V   | ~ +40°   | ~ +40°C 3.3 |           | -      | 0.4    | 2.5      | μA    |  |
|        |                                     | S1#≤0.2V, S2≥ Vcc-0.2V<br>other inputs=0~Vcc   |          |             | 3.6V      |        |        | 4.0      |       |  |
|        |                                     | otner inputs=0~ vcc  | ~ +70°   | С           | 3.0V~3.6V | -      | -      | 10       |       |  |
|        |                                     |  | ~ +85°   | С           | 3.0V~3.6V | -      | 1      | 20       |       |  |
| lcc4   | Stand by supply current (TTL level) | BC1# and BC2# =VH or S1# =VH<br>Other inputs= 0 ~ Vcc  | or S2=Vi | L           |           | -      | -      | 2        | mA    |  |

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

### **CAPACITANCE**

(Vcc= $2.7 \sim 3.6$ V, unless noted.)

| Symbo | Doromotor          | Conditions                |     | 11.24 |     |       |
|-------|--------------------|---------------------------|-----|-------|-----|-------|
|       | Parameter          | Conditions                | Min | Тур   | Max | Units |
| Сі    | Input capacitance  | V⊨GND, V⊨25mVrms, f=1MHz  |     |       | 10  | pF    |
| Со    | Output capacitance | Vo=GND,Vo=25mVrms, f=1MHz |     |       | 10  | рг    |



<sup>\* -1.0</sup>V in case of AC (Pulse width  $\leq$  30ns)

Note 2: Typical parameter indicates the value for the center of distribution at 3.00V, and is not 100% tested.

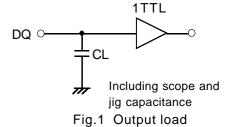
### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

### AC ELECTRICAL CHARACTERISTICS

(Vcc= $2.7 \sim 3.6$ V, unless noted.)

### (1) TEST CONDITIONS

| Supply voltage                | 2.7~3.6V  |
|-------------------------------|---|
| Input pulse                   | V⊩=2.4V, V⊫=0.2V  |
| Input rise time and fall time | 5ns   |
| Reference level               | VoH=Va=1.50V Transition is measured ±200mV from steady state voltage.(for ten,tdis) |
| Output loads                  | Fig.1,CL=30pF<br>CL=5pF (for ten,tdis)  |



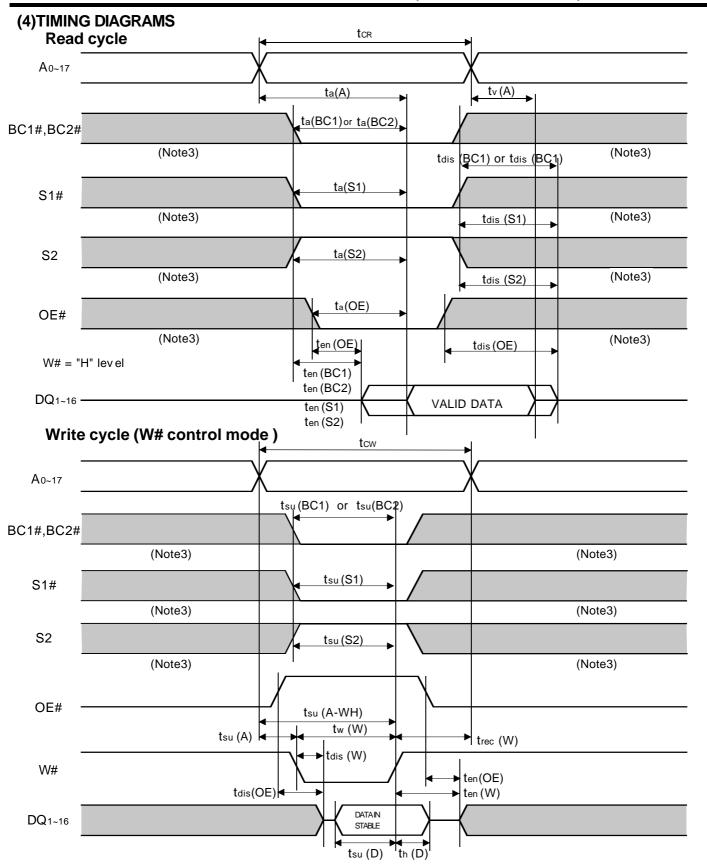
### (2) READ CYCLE

|  |                                     | Lin | nits | Lin | nits |       |
|--|-------------------------------------|-----|------|-----|------|-------|
| Symbol   | Parameter                           | 55  | HI   | 70  | HI   | Units |
| , and the second |                                     | Min | Max  | Min | Max  |       |
| tcr  | Read cycle time                     | 55  |      | 70  |      | ns    |
| ta(A)  | Address access time                 |     | 55   |     | 70   | ns    |
| ta(S1)   | Chip select 1 access time           |     | 55   |     | 70   | ns    |
| ta(S2)   | Chip select 2 access time           |     | 55   |     | 70   | ns    |
| ta(BC1)  | Byte control 1 access time          |     | 55   |     | 70   | ns    |
| ta(BC2)  | Byte control 2 access time          |     | 55   |     | 70   | ns    |
| ta(OE)   | Output enable access time           |     | 30   |     | 35   | ns    |
| tdis(S1)   | Output disable time after S1# high  |     | 20   |     | 25   | ns    |
| tdis(S2)   | Output disable time after S2 low    |     | 20   |     | 25   | ns    |
| tdis(BC1)  | Output disable time after BC1# high |     | 20   |     | 25   | ns    |
| tdis(BC2)  | Output disable time after BC2# high |     | 20   |     | 25   | ns    |
| tdis(OE)   | Output disable time after OE# high  |     | 20   |     | 25   | ns    |
| ten(S1)  | Output enable time after S1# low    | 10  |      | 10  |      | ns    |
| ten(S2)  | Output enable time after S2 high    | 10  |      | 10  |      | ns    |
| ten(BC1)   | Output enable time after BC1# low   | 5   |      | 5   |      | ns    |
| ten(BC2)   | Output enable time after BC2# low   | 5   |      | 5   |      | ns    |
| ten(OE)  | Output enable time after OE# low    | 5   |      | 5   |      | ns    |
| t∨(A)  | Data valid time after address       | 10  |      | 10  |      | ns    |

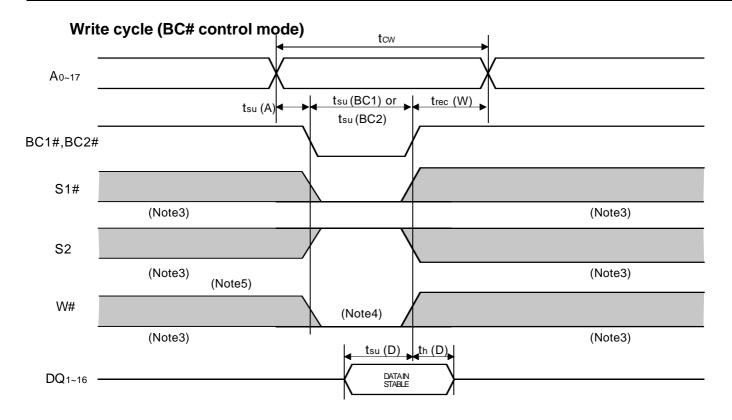
### (3) WRITE CYCLE

|                    |                                       | Lin | nits | Limits |     |       |
|--------------------|---------------------------------------|-----|------|--------|-----|-------|
| Symbol             | Parameter                             | 55  | HI   | 70     | HI  | Units |
| Í                  |                                       | Min | Max  | Min    | Max |       |
| tcw                | Write cycle time                      | 55  |      | 70     |     | ns    |
| t <sub>w</sub> (W) | Write pulse width                     | 45  |      | 55     |     | ns    |
| tsu(A)             | Address setup time                    | 0   |      | 0      |     | ns    |
| tsu(A-WH)          | Address setup time with respect to W# | 50  |      | 60     |     | ns    |
| tsu(BC1)           | Byte control 1 setup time             | 50  |      | 60     |     | ns    |
| tsu(BC2)           | Byte control 2 setup time             | 50  |      | 60     |     | ns    |
| tsu(S1)            | Chip select 1 setup time              | 50  |      | 60     |     | ns    |
| tsu(S2)            | Chip select 2 setup time              | 50  |      | 60     |     | ns    |
| tsu(D)             | Data setup time                       | 30  |      | 35     |     | ns    |
| th(D)              | Data hold time                        | 0   |      | 0      |     | ns    |
| trec(W)            | Write recovery time                   | 0   |      | 0      |     | ns    |
| tdis(W)            | Output disable time from W# low       |     | 20   |        | 25  | ns    |
| tdis(OE)           | Output disable time from OE# high     |     | 20   |        | 25  | ns    |
| ten(W)             | Output enable time from W# high       | 5   |      | 5      |     | ns    |
| ten(OE)            | Output enable time from OE# low       | 5   |      | 5      |     | ns    |

### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

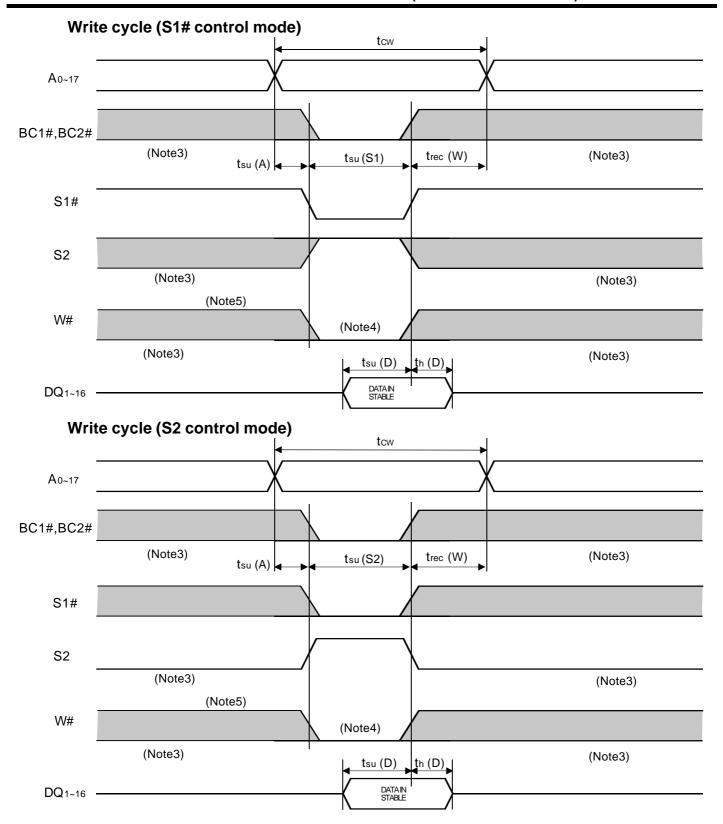


### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM



- Note 3: Hatching indicates the state is "don't care".
- Note 4: A Write occurs during S1# low, S2 high overlaps BC1# and/or BC2# low and W# low.
- Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.
- Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.

### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM



### 4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

### **POWER DOWN CHARACTERISTICS**

### (1) ELECTRICAL CHARACTERISTICS

| 0                                      | Danamatan                           |  |         |         |         |     |       |
|--|-------------------------------------|--|---------|---------|---------|-----|-------|
| Symbol                                 | Parameter                           | Test conditions  |         | Min     | Тур     | Max | Units |
| Vcc (PD)                               | Power down supply voltage           |  |         | 2.0     |         |     | V     |
| Vi (DO)                                | Byte control input BC1# &           | 2.2V <u>≤</u> Vcc(PD)  |         | 2.2     |         |     |       |
| VI (BC) Byte control input BC1# & BC2# | 2.0V <u>≤</u> Vcc(PD) <u>≤</u> 2.2V | <u>≤</u> 2.2V  |         | Vcc(PD) |         | V   |       |
| V((04)                                 | 2.2V ≤ Vcc(PD)                      |  | 2.2     |         |         |     |       |
| VI (S1)                                | Chip select input S1#               | 2.0V ≤ Vcc(PD) ≤ 2.2V  |         |         | Vcc(PD) |     | V     |
| VI (S2)                                | Chip select input S2                |  |         |         |         | 0.2 | V     |
|  |                                     | Vcc=2.0V<br>(1) S1#>Vcc-0.2V,  | ~ +25°C | -       | 0.05    | 8.0 |       |
| Icc (PD)                               | Power down                          | other inputs = 0 ~ Vcc<br>(2) S2 ≤ 02V,                              | ~ +40°C | -       | 0.1     | 1.5 |       |
| ICC (PD)                               | supply current                      | other inputs = 0 ~ Vcc<br>(3) BC1# and BC2#≥ Vcc - 0.2V              | ~ +70°C | -       | -       | 7.5 | μΑ    |
|  |                                     | $S1\# \le 0.2V$ , $S2 \ge Vcc - 0.2V$<br>other inputs = $0 \sim Vcc$ | ~ +85°C | -       | -       | 15  |       |

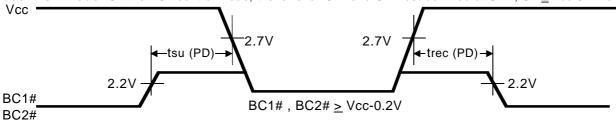
Note 7: Typical parameter of Icc(PD) indicates the value for the center of distribution at 2.0V, and not 100% tested.

### (2) TIMING REQUIREMENTS

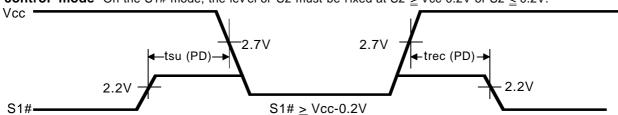
| Symbol    | _                        |                 |     | 11.24 |     |       |
|-----------|--------------------------|-----------------|-----|-------|-----|-------|
|           | Parameter                | Test conditions | Min | Тур   | Max | Units |
| tsu (PD)  | Power down set up time   |                 | 0   |       |     | ns    |
| trec (PD) | Power down recovery time |                 | 5   |       |     | ms    |

### (3) TIMING DIAGRAM

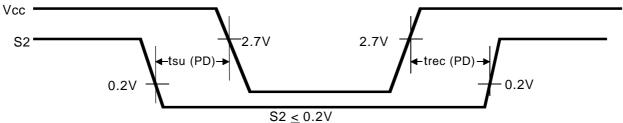
**BC# control mode** On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2  $\geq$  Vcc-0.2V or S2  $\leq$  0.2V.



**S1#** control mode On the S1# mode, the level of S2 must be fixed at S2  $\geq$  Vcc-0.2V or S2  $\leq$  0.2V.







4194304-BIT (262144-WORD BY 16-BIT) CMOS STATIC RAM

# Renesas Technology Corp.

Nippon Bldg.,6-2,Otemachi 2-chome,Chiyoda-ku,Tokyo,100-0004 Japan

#### Keep safety first in your circuit designs!

• Reneasa Fechnology Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

#### Notes regarding these materials

- These materials are intended as a reference to assist our customers in the selection of the Renesas Technology Corporation product best suited to the customer's application; they do not convey any license under any intellectual
- In less materials are intended as a reference to assist our customers in the selection of the Kenesas I echnology Corporation product best suited to the customer's application; they do not convey any license under any intellect property rights, or any other rights, belonging to Renesas Technology Corporation or a third party.

  Renesas Technology Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.

  All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Renesas Technology Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Renesas Technology Corporation or an authorized Renesas Technology Corporation before purchasing a product listed herein.

- Corporation product distributor of the latest product instrumtion before purchasing a product instead nerein.

  The information described here may contain technical inaccuracies or typographical errors.

  Renesas Technology Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.

  Please also pay attention to information published by Renesas Technology Corporation by various means, including the Renesas Technology Corporation Semiconductor home page (http://www.renesas.com).

  When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Renesas Technology Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.

  Renesas Technology Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation semiconductors are not designed or manufacture for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation semiconductors are not designed or manufacture for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation semiconductors are not designed or manufacture for use in a device or system that is used under circumstances in which will be a supported to the contained herein for any specific purposes, such as apparatus or systems for transportat
- medical, aerospace, nuclear, or undersea repeater use
- The prior written approval of Renesas Technology Corporation is necessary to reprint or reproduce in whole or in part these materials.

  If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved
- destination.

  Any diversion or reexport contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited Please contact Renesas Technology Corporation for further details on these materials or the products contained therein.



